


<b>Search Notes</b>  	<b>Application/Control No.</b>  10512003	<b>Applicant(s)/Patent Under Reexamination</b>  BAMBACH, RAMON JOHN
	<b>Examiner</b>  BENJAMIN P LEE	<b>Art Unit</b>  3641

SEARCHED			
Class	Subclass	Date	Examiner
102	345	2/8/2008	LEE
102	352	2/8/2008	LEE
102	335	2/8/2008	LEE
102	360	2/8/2008	LEE
102	438	2/8/2008	LEE
102	217	2/8/2008	LEE
89	20.1	2/8/2008	LEE
42	84	2/8/2008	LEE

SEARCH NOTES		
Search Notes	Date	Examiner
updated search	2/8/2008	LEE

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner